



## Instrumentation, Noise, Reliability

Collection Editor:

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### Message from the Collection Editor

Dear colleagues,

This topic collection aims to collect contributions on the design of new measurement systems and circuits, dedicated to applications in various fields (medicine, biology, environment, sport, food, agriculture, industry, electronic devices and materials characterization), that are smart, fast, performing, portable, programmable or that in any case introduce a degree of novelty with respect to the state of the art. Interest is also addressed to the techniques for the characterization of the reliability of new materials and devices, among which low frequency noise measurements, in particular (but not only), due to their growing diffusion also in the field of sensors, play a fundamental role.





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## Editor-in-Chief

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## Message from the Editor-in-Chief

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